

Underlying Principles, Design, Construction, Test, and Uncertainties of the New NIST Coaxial Radiometer NFRad

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Outline

#Part I. Theory and Background

- < Probability & Statistical Mechanics background
- < Nyquist Theorem
- < Microwave networks and noise
- < Amplifiers & noise
- < Isolated total-power radiometer, radiometer equation
- < Unisolated total power radiometer

#Part II. NFRad Design and Construction

- < System overview, major components
- < Important requirements and features
- < Switch head
- < Receiver
- < IF Section
- < Switching and interfaces
- < Electronics rack
- < Plumbing

#Part III. Operation, Testing, and Uncertainties

- < Operation
- < Software
- < Testing
- < Uncertainties
- < Measurements through adapters

PART I.

THEORY AND BACKGROUND

Outline

#Probability, statistical mechanics
background

#Nyquist Theorem

#Microwave networks and noise

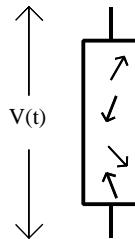
#Amplifiers & noise

#Isolated total-power radiometer,
radiometer equation

#Unisolated total power radiometer

Probability, Statistical Mechanics Background [1]

#Thermal motion ± fluctuating current & voltage



$$I(t) = 3i_i(t) = e^{-3} v_i(t)$$

$$V(t) = I(t) R$$

$$\langle I(t) \rangle = \langle V(t) \rangle = 0$$

$$\langle V^2 \rangle, \langle I^2 \rangle \propto T \dots 0$$

$$\langle P \rangle \propto T \dots 0$$

#Fluctuating functions & probability

- < Ensemble & time averages; stationary, ergodic systems
- < (Auto) Correlation Function

Define autocorrelation function

$$K(s) \equiv \langle V(t) V(t+s) \rangle_{equil} .$$

$K(0)$ is the dispersion (if $\langle V \rangle = 0$),

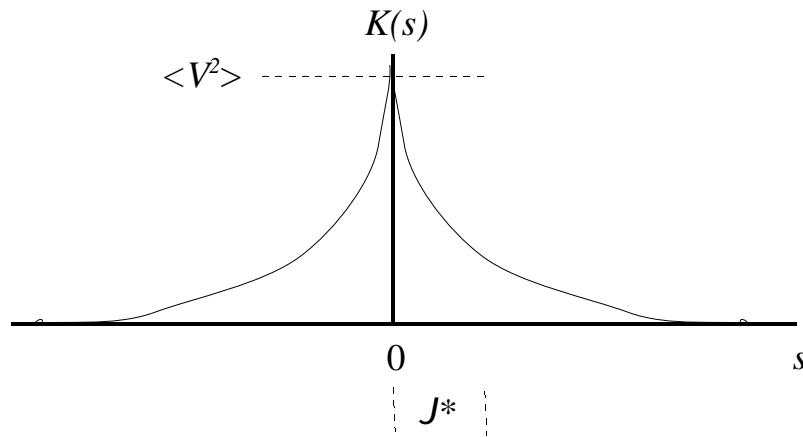
$$K(0) = \langle V^2(t) \rangle > 0 .$$

$K(s)$ is independent of t ; can show that

$$K(s)^* = K(0) ; \quad K(s) = K(-s) .$$

#Fluctuating functions & probability

- < Correlation time J^* ; $K(s) \neq 0$ for $s \gg J^*$.
- < Correlation function looks roughly like



#Fourier Transform of fluctuating function:

- < FT not defined for random function defined over all time, so restrict function to $t \in [0, T]$ (T very large),

$$\nu_1(t) = \begin{cases} \nu(t), & t \in [0, T] \\ 0 & \text{otherwise.} \end{cases}$$

Then

$$\begin{aligned} \nu_1(T) &= \frac{1}{2\pi} \int_{-\infty}^{\infty} \nu_1(t) e^{-i\omega t} dt, \\ \nu_1(t) &= \frac{1}{2\pi} \int_{-\infty}^{\infty} \nu_1(\omega) e^{i\omega t} d\omega. \end{aligned}$$

#Correlation Function & Wiener-Khintchine Relation

- < Let $K(s)$ be the correlation function for v and define its FT $J(\mathcal{T})$,

$$\begin{aligned} K(s) &\stackrel{4}{\sim} \langle v_1(t) v_1(t+s) \rangle, \\ K(s) &\stackrel{\mathbf{m}}{\sim} J(\mathcal{T}) e^{\&i\mathcal{T}s} d\mathcal{T}, \\ J(\mathcal{T}) &\stackrel{4}{\sim} \frac{1}{2B} \mathbf{m} \int_{-B}^B K(s) e^{\&i\mathcal{T}s} ds. \end{aligned}$$

- < These are Wiener-Khintchine Relations; to make them meaningful, must give physical meaning to $J(\mathcal{T})$.

#Wiener-Khintchine (cont'd)

- < Consider $K(0)$,

$$\langle v^2(t) \rangle \stackrel{4}{\sim} K(0) \stackrel{\mathbf{m}}{\sim} \int_{-\infty}^{\infty} J(\mathcal{T}) d\mathcal{T},$$

so that the average power dissipated in a resistance R is given by

$$\langle P \rangle \stackrel{R}{\sim} \frac{\langle v^2 \rangle}{R} \stackrel{4}{\sim} \frac{1}{R} \int_{-\infty}^{\infty} J(\mathcal{T}) d\mathcal{T} \stackrel{4}{\sim} \frac{1}{R} \int_0^\infty J_+(\mathcal{T}) d\mathcal{T},$$

where $J_+(\mathcal{T}) = J(\mathcal{T}) + J(-\mathcal{T})$.

- < So J_+ is the spectral density of v , or R times the power spectral density.

#Wiener-Khintchine (cont'd)

< Also can relate J to v_1 by using

$$K(s) = \langle v_1(t) v_1(t+s) \rangle = \langle v_1(0) v_1(s) \rangle + \frac{1}{2B} \int_{-B}^B v(t) v(t+s) dt$$

in

$$J(T) = \frac{1}{2B} \int_{-B}^B K(s) e^{iTs} ds.$$

Regroup, recognize expressions for * functions, to get

$$J(T) = \frac{B}{4} * v_1(T)^2.$$

Nyquist Theorem [1]

#Fluctuation-Dissipation Theorem:

< Usual (mechanical) treatment

$$m \frac{dv}{dt} = \dot{\Theta}(t) - F(t)$$

$\dot{\Theta}(t)$ is external force, slowly varying

$F(t)$ is internal, contains slow (F_0) and fast (F_H) variation

$$F(t) = F_0 + v F_H(t), \quad m \frac{dv}{dt} = \dot{\Theta}(t) - v F_H(t)$$

v is friction constant. Can show

$$v = \frac{1}{2k_B T} \langle F(0) F(s) \rangle_{eq} ds$$

#Fluctuation-Diss. Thm (cont'd)

< Electrical case, conductor with self inductance and resistance

$$L \frac{dI}{dt} + V_{ext}(t) \approx V(t) + V_{ext}(t) \neq RI \neq V\mathbb{M}(t) \quad (\text{Langevin eqn})$$

Then

$$R + \frac{1}{2k_B T} \int_0^B \langle V(0)V(s) \rangle_{eq} ds = \frac{1}{2k_B T} 2B J(0)$$

$$J_{\%}(0) = \frac{2k_B T R}{B}$$

#Nyquist Theorem

< $J(T)$ constant for $T \ll 1/J^*$,

$$J(T) = \frac{1}{2B} \int_0^B K(s) e^{-iTs} ds$$

$K(s) \neq 0$ for $s \gg J^*$, so $T \ll 1/J^* \Rightarrow Ts \ll 1$. Therefore

$$J(T) = \frac{1}{2B} \int_0^B K(s) 1 ds = J(0)$$

So for $T \ll 1/J^*$

$$J_{\%}(T) = \frac{2}{B} k_B T R$$

#Nyquist Theorem (cont'd)

< So then

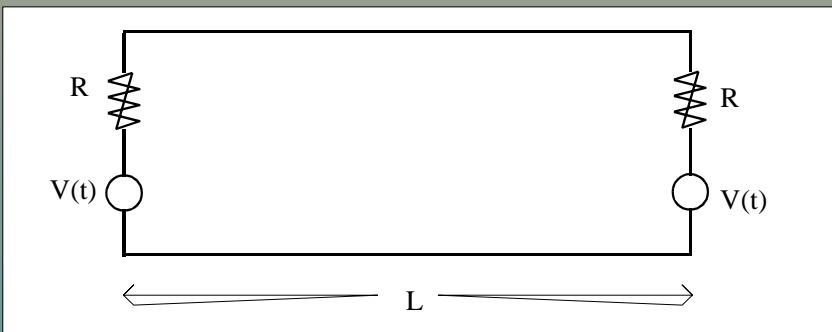
$$\begin{aligned} \langle P_{res} \rangle &= \frac{\langle *V^2 \rangle}{R} \cdot \frac{1}{R} \int_0^T J_{\%}(T) dT + \frac{2k_B T}{B} m dT \\ \frac{d\langle P_{avail} \rangle}{df} &= \frac{1}{R} \langle V/2 \rangle^2 + k_B T, \\ \langle P_{avail}(f) \rangle &= k_B T df \end{aligned}$$

< With quantum effects, it's really

$$\langle P_{avail}(f) \rangle = \left(\frac{hf}{e^{\frac{hf}{k_B T}} - 1} \right) df$$

#Nyquist's derivation (with quantum update)

- < Long transmission line, connecting identical R's
- < Characteristic impedance R
- < All in equilibrium at temperature T



#Nyquist's derivation (cont'd)

- < $V(t)$ is the noise voltage in each resistor.
- < One-dimensional black body problem.
- < Voltage wave, $V = V_0 \exp[i(\mathcal{T}t - kx)]$,
velocity $c\mathbb{H} = \mathcal{T}k$.
- < Count the number of modes:

Periodic boundary conditions: $V(x=L) = V(0)$, so $kL = 2Bn$.

Number of modes per unit length is then $\lambda n = dk/(2B)$ between k and $k+\lambda k$, or between \mathcal{T} and $\mathcal{T}+\lambda \mathcal{T}$.

#Nyquist's derivation (cont'd)

- < From Planck distribution (B-E stats) the average number of photons in mode with frequency f_j is

$$\bar{n}_j = \frac{1}{e^{hf_j/(k_B T)} + 1}$$

- < Energy of one photon in that mode is hf , so average energy in mode with f is

$$\langle , \rangle = \frac{hf}{e^{hf/(k_B T)} + 1}$$

- < No reflections, so power incident on resistor is all absorbed.

#Nyquist's derivation (cont'd)

- < Thermal equilibrium, so power emitted = power absorbed (in each small frequency band T to $T+dT$, detailed balance).
- < Velocity×modes per length×energy per mode = energy per time absorbed/emitted,

$$dP_{em} = dP_{abs} = cN \times \left(\frac{1}{2B} \frac{dT}{cN} \right) \times \langle J(T) \rangle = \frac{1}{2B} \left(\frac{hf}{e^{hf/(k_B T)} - 1} \right) dT$$

- < The V from one resistor causes $I = V/(2R)$ to flow in the circuit, dissipating a power $P = R\langle I^2 \rangle = \langle V^2 \rangle / (4R)$ in the other resistor.

#Nyquist's derivation (cont'd)

- < That power must be the power emitted from the first resistor, so

$$\frac{\langle V^2 \rangle}{4R} = \frac{1}{4R} \int_0^4 J_0(T) dT = \frac{1}{2B} \int_0^4 \left(\frac{hf}{e^{hf/(k_B T)} - 1} \right) dT$$

$$J_0(T) = \frac{2}{B} \left(\frac{hf}{e^{hf/(k_B T)} - 1} \right) R$$

etc.

#Quantum cutoff: $f(\text{GHz}) \cdot 20 T(\text{K})$

#In practice

$$< h/k_B = 0.04799 \text{ K/GHz}$$

$$\begin{aligned} & < P_{\text{avail}}(f) > = \left(\frac{hf}{1 + \frac{hf}{k_B T}} \right)^2 \frac{1}{2} \left(\frac{hf}{k_B T} \right)^2 \cdot 1 \\ & \cdot k_B T [1 + \frac{hf}{2k_B T}] df \end{aligned}$$

< So at 290 K, 1 % effect at 116 GHz;
 at 100 K, 1 % effect at 40 GHz;
 at 100 K, 0.1 % effect at 4 Ghz.

#Define: Noise Temperature (f) /
 [Available power spectral density]/ k_B ,
 so

$$P_{\text{avail}} = k_B T_{\text{noise}} f$$

#So for passive device

$$T_{\text{noise}} = \frac{1}{k_B} \left(\frac{hf}{e^{\frac{hf}{k_B T}} - 1} \right)$$

Microwave Networks & Noise [2,3]

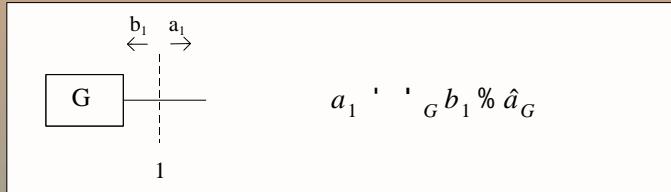
#Assume lossless lines, single mode.

#Travelling wave amplitudes a, b .

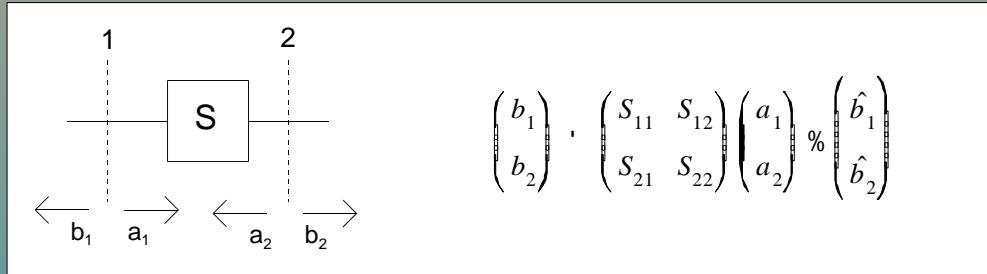
#Normalized such that $P_{del} = |a|^2 + |b|^2$

#May be a little careless about B;
assume it's 1 Hz where needed.

#Describe (linear) one-ports by



#And (linear) two-ports by



#Available power:

$$P_G^{(avail)} = \frac{|\hat{a}_G|^2}{1 + |\hat{a}_G|^2} = \langle |\hat{a}_G|^2 \rangle \cdot (1 + |\hat{a}_G|^2) k_B T_G$$

#Delivered power:

$$P_1^{del} = |\hat{a}_1|^2 = |\hat{a}_1|^2 (1 + |\hat{a}_1|^2) k_B T_L$$

#Mismatch factor: $M_1 / p_{1,avail} / p_{1,del}$

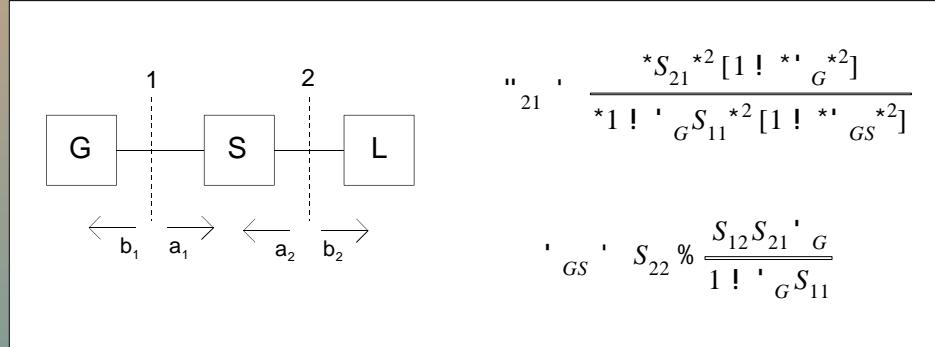
$$M_1 = \frac{(1 + |\hat{a}_1|^2)(1 + |\hat{a}_L|^2)}{1 + |\hat{a}_1|^2 + |\hat{a}_L|^2}$$

#Efficiency: $O_{21} / p_{2,del} / p_{1,del}$

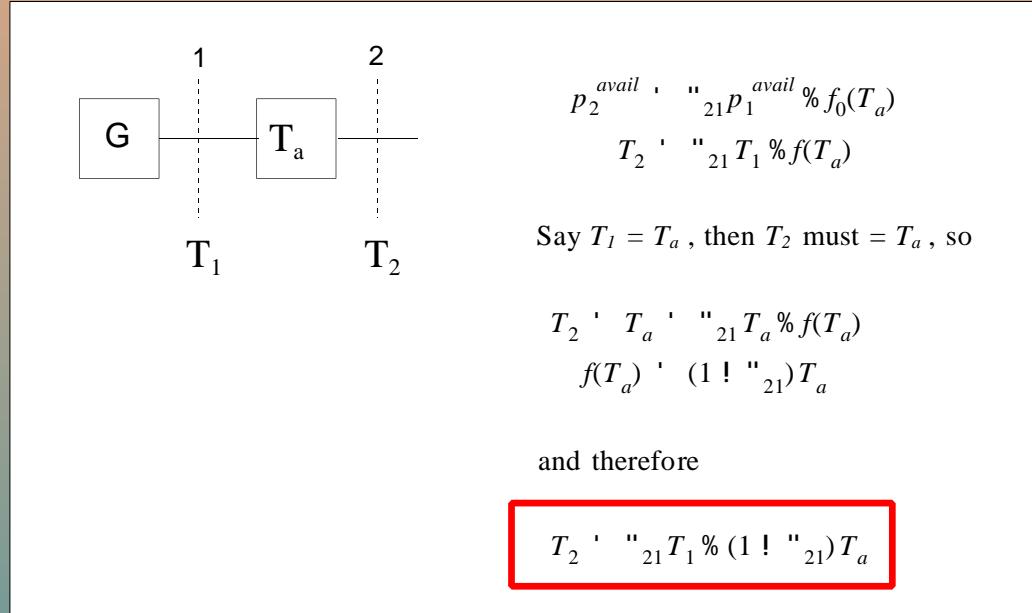
$$O_{21} = \frac{|\hat{a}_{21}|^2 [1 + |\hat{a}_L|^2]}{1 + |\hat{a}_{21}|^2 + |\hat{a}_L|^2}$$

$$O_{21} = \frac{|\hat{a}_{21}|^2 [1 + |\hat{a}_L|^2]}{1 + |\hat{a}_{21}|^2 + |\hat{a}_L|^2 + (S_{12} S_{21} - S_{11} S_{22}) + |S_{11}|^2}$$

#Available power ratio:
 $"_{21} / p_{2,avail} / p_{1,avail} (\theta_1, \theta_2 = 0)$



#For passive devices:



#Practical: large vs. small T_1

Amplifiers & Noise [4–7]

#Linear two-port:

$$\begin{pmatrix} b_1 \\ b_2 \end{pmatrix} = \begin{pmatrix} S_{11} & S_{12} \\ S_{21} & S_{22} \end{pmatrix} \begin{pmatrix} a_1 \\ a_2 \end{pmatrix} + \begin{pmatrix} \hat{b}_1 \\ \hat{b}_2 \end{pmatrix}$$

#Four real noise parameters:

$$\langle * \hat{b}_1^* \hat{b}_1 \rangle, \langle * \hat{b}_2^* \hat{b}_2 \rangle, \langle \hat{b}_1 \hat{b}_2^\dagger \rangle$$

#Output noise temperature T_2

$$k_B T_2 = \frac{*S_{21}^*}{(1 & *_{GS}^*)} [N_G \& N_1 \& N_2 \& N_{12}]$$

$$N_G = \frac{(1 & *_{G}^*)}{*1 & *_{G}^* S_{11}^*} T_G$$

$$N_1 = \frac{2}{1 & *_{G}^* S_{11}^*} \langle * \hat{b}_1^* \hat{b}_1 \rangle$$

$$N_2 = \langle * \hat{b}_2^* / S_{21}^* \rangle$$

$$N_{12} = 2 \operatorname{Re} \left[\frac{1}{(1 & *_{G}^* S_{11}^*)} \langle \hat{b}_1 (\hat{b}_2 / S_{21})^\dagger \rangle \right]$$

#Important point: T_2 depends on γ_G .
 So same T_G can give different T_2 ,
 depending on γ_G .

#IEEE parameterization [8–10]
 (actually a variation [4] of it):

$$T_e = T_{e,\min} \cdot 4 T_0 \frac{R_n}{Z_0} \frac{\gamma_G \cdot \gamma_{opt}}{\gamma_{opt}^2 + (1 - \gamma_G)^2}$$

$$T_2 = G(T_G \cdot T_e)$$

#Noise figure is defined by

$$F(dB) = 10 \log_{10} \left(\frac{T_e \cdot T_0}{T_0} \right)$$

$$T_0 = 290 \text{ K}$$

#Measure noise parameters by
 measuring T_2 for various T_G and γ_G .

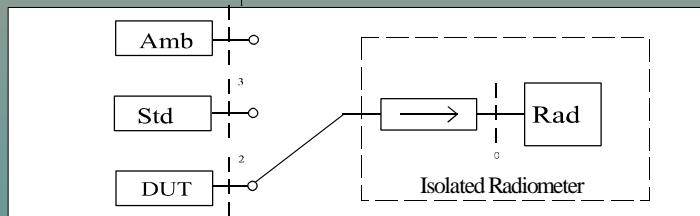
#Etc.

Isolated, Total-Power Radiometer [11,12]

NIST
NOISE

#Basic idea: $P_{\text{meter}} = a + bP_{\text{in}}$

#Measure two standards; determine
a (-system noise temperature) and
b (system gain).

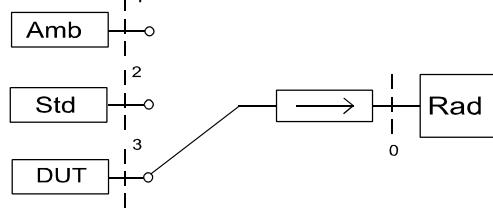


#System characteristics (a, b) must not change with source, so use isolators.

P_{in} is minuscule, so amplify; LNA first. (100 K - 1.38 fW/MHz)

#Filter, downconvert to IF, amplify & filter some more.

#Radiometer equation:



$$\begin{aligned}
 p_{0,x} &= M_{0,x} O_{03} P_x \% M_{0,x} (1 - O_{03}) P_a \% p_{ex} \\
 p_{0,S} &= M_{0,S} O_{02} P_S \% M_{0,S} (1 - O_{02}) P_a \% p_{eS} \\
 p_{0,a} &= M_{0,a} O_{01} P_a \% M_{0,a} (1 - O_{01}) P_a \% p_{ea} + M_{0,a} P_a \% p_{ea}
 \end{aligned}$$

< Where P is available power & p is delivered power.

#Radiometer equation (cont'd)

< Use $M_{0,x} O_{03} = M_3 O_{03}$, $M_{0,S} O_{02} = M_S O_{02}$ to get

$$\begin{aligned}
 p_{0,x} &= M_3 O_{03} (P_x + P_a) \% M_{0,x} P_a \% p_{ex} \\
 p_{0,S} &= M_S O_{02} (P_S + P_a) \% M_{0,S} P_a \% p_{eS} \\
 p_{0,a} &= M_{0,a} P_a \% p_{ea}
 \end{aligned}$$

< Because of the isolator, $M_{0,x} = M_{0,S} = M_{0,a}$ and $p_{ex} = p_{eS} = p_{ea}$, and so

$$\begin{aligned}
 p_{0,x} &= M_3 O_{03} (P_x + P_a) \% p_{0,a} \\
 p_{0,S} &= M_S O_{02} (P_S + P_a) \% p_{0,a}
 \end{aligned}$$

#Radiometer equation (cont'd)

- < Rearrange a bit and divide one by the other to get

$$\frac{p_{0,x} ! p_{0,a}}{p_{0,S} ! p_{0,a}} , \frac{M_x \Omega_{03}(P_x ! P_a)}{M_S \Omega_{02}(P_S ! P_a)}$$

- < Use $P = k_B T B$ and rearrange some more to get the RADIOMETER EQUATION:

$$T_x = T_a \cdot \frac{M_S \Omega_{02}}{M_x \Omega_{03}} \frac{(Y_x ! 1)}{(Y_S ! 1)} (T_S ! T_a)$$

Unisolated, Total-Power Radiometer [13]

#Below about 1 GHz, isolators get large & cumbersome.

#Two options for total-power radiometer for low frequencies:

- < Tunable standards [14]
- < Characterize system as function of input

#Tunable standards [14]: big disadvantage is that they are essentially single frequency.

#Characterize radiometer [13]: receiver noise temperature and gain vary with Γ_G same way amplifier's do. Measure two known noise temperatures and several different known impedances to determine radiometer parameters at each frequency.

Summary: Essential Results

#Noise temperature is defined by

$$P_{avail} = k_B T_{noise} \cdot f$$

#For a passive one-port device

$$T_{noise} = \frac{1}{k_B} \left(\frac{hf}{e^{\frac{hf}{k_B T_{phys}}} - 1} \right) + T_{phys}$$

#For a passive two-port

$$T_2 = T_1 \frac{(1 + \frac{1}{T_{21}})}{(1 + \frac{1}{T_{21}}) - T_a}$$

#Radiometer equation for isolated,
total-power radiometer

$$T_x = T_a \frac{\frac{M_S O_{02}}{M_x O_{03}} \frac{(Y_x + 1)}{(Y_S + 1)}}{(T_S + T_a)}$$